Search Notes

1	Application/Control No.	Applicant(s)/Patent under Reexamination	
1	09/190,207	CHEN, JIASHU	
Π	Examiner	Art Unit	_
1	Duc Nguyen	2643	

	SEARCHED				
Class	Subclass	Date	Examiner		
Updated	search	3/2/2006	DN		
same	as				
all	previous				
	searches				
		l			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		,	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Interference search included	3/3/2006	DN		